承認書

SPECIFICATION FOR APPROVA

CUSTOMER:			
CUSTOMER P/N:			
CUSTOMER PART NO:			
DESCRIPTION:	SMD INDUCTOR		
PRODUCTS NO:	BCIHP0730-8R2M		
PFIRST DATE:	2019-8-16		BC REV: X1
DATE:	2019-8-16		
	PURCHASER CON	FIRMED	
	PURCHASER CON	FIRMED	
DEMARK			
REMARK			

PROVIDER ENGINEER DEPT.						
APPROVAL BY CHECK BY DRAWN BY						
ouyangweijun	ouyangweijun	chenlinli				

CHENG 誠陽實業有限公司

TAIPEI OFF ICE TAIWAN CHENG YANG COMPONENT CORP

2F-1, NO. 176, Chine-Yi Road., Zhonghe District, New Taipei City, TAIWAN(R.O.C)

新北市中和區建一路176號2樓之一

POSTAL CODE: 23500

TEL NO.:+886-2-8228-0930 FAX NO.:+886-2-8228-0929 E-mail:h21803@ms29.hinet.net



寶誠電子有限公司

CHINA FACTORYZHUHAI BAO CHENG ELECTRONICSCO.,LTD

Guan Tang Industrial Park, Tang Jia Wan Town, Zhuhai City, Guangdong Province, CHINA

中國廣東省珠海市塘家灣鎮官塘工業區

POSTAL CODE: 519085

TEL NO:86-756-3383187 FAX NO:86-756-3380704 E-mail: baocheng@baocheng.biz

CHENG 昆山誠陽電子有限公司

CHINA FACTORYKUNSHAN CHENG YANG ELECTRONICSCO.,LTDP

江蘇省昆山市高科技工業園區強安路35號

POSTAL CODE: 215300

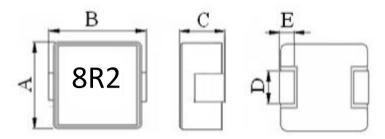
TEL NO:86-512-57823500 FAX NO:86-512-57823503 E-mail: kscy@taiwan-chengyang.com.tw

SPECIFICATION FOR APPROVAL

DATE: 2019-8-16

CUSTOMER:	CUSTOMER PART NO:	PFIRST DATE:	
0		2019-8-16	
DESCRIPTION:	PRODUCTS NO:	BC REV:	
SMD INDUCTOR	BCIHP0730-8R2M	X1	

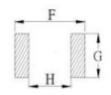
1.CONFIGURATION DIMENSIONS



DIMENSIONS (UNIT:mm)

A: 6.80 Max
B: 7.30 Max
C: 3.00 Max
D: 3.00 ±0.3
E 1.60 ±0.3

2.RECOMMEND LAND PATTERN DIMENSIONS



F: 7.55

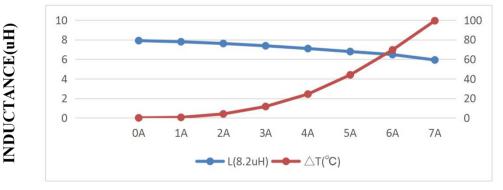
G: 3.35

H 2.40

3.ELECTRICAL CHARACTER

Part Number	Inductance (uH)	$R_{dc}(m\Omega)$	⁽⁵⁾ (Irms)(A) Heat Rating Current	(6) (Isat)(A) Saturation Current	
	200kHz/0.25v/0A.	Typical Max	Typical	Typical	
BCIHP0730-8R2M	8.2 ± 20%	63.0 68.0	4.0 △T≦40°C	6.0 △L≦20%	

Adc	0A	1A	2A	3A	4A	5A	6A	7A
L(8.2uH)	7.903	7.787	7.609	7.374	7.093	6.783	6.475	5.925
$\wedge T(^{\circ}C)$	0.00	0.50	4.00	11.60	24.30	44.00	69.54	99.39



TEMPERATURE (°C)

- (1) Tolerance of Inductance: M=±20%.
- (2) All test data is referenced to 25°C ambient.

DC CURRENT (AMPS)

- (3) Inductance is measured at 200kHz/0.25v/0A.25°C ambient.
- (4) Operating Temperature Range -40°C to +125°C.
- (5) DC current (Irms) (A) that will cause an Approximate $\triangle T \le 40^{\circ}$ C
- (6) DC current (Isat) (A) that will cause L0 to drop approximately $\triangle L \le 20\%$
- (7) The part Temperature (ambient + temp rise) should not exceed 125°C under worst case operating conditions. Circuit design, component placement, PWB trace size and thickness, airflow and other cooling provisions all affect the part temperature Part temperature should be verified in the end application.
- ※Irms: Heat Rating Current DC Amps.

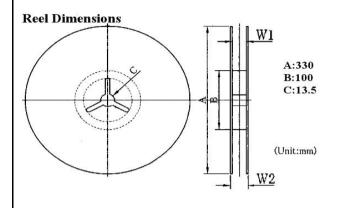
SPECIFICATION FOR APPROVAL

DATE: 2019-8-16

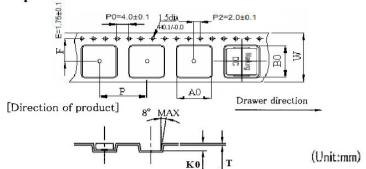
CUSTOMER:	CUSTOMER PART NO:	PFIRST DATE:		
0		2019-8-16		
DESCRIPTION:	PRODUCTS NO:	BC REV:		
SMD INDUCTOR	BCIHP0730-8R2M	X1		

4.PACKAGING INFORMATION

(1) Tape Dimension / Packaging Quantity



Tape Dimensions



DIMENSIONS (UNIT:mm)

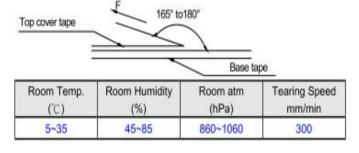
A: 330.0 ±2.00 B: 100.0 ±0.50 C: 13.5 ±0.50 W1: 16.80 ±0.30 W2: 23.10 ±0.50

Q'TY: 1,000 PCS

DIMENSIONS (UNIT:mm)

W: 16.00 ± 0.30 A0: 7.10 ± 0.10 B0: 7.60 ± 0.10 K0: 3.50 ± 0.10 P: 12.00 ± 0.10 F: 7.50 ± 0.10 T: 0.40 ± 0.05

(2) Tearing Off Force



The force tearing off cover 10 to 130 grams (0.1N to 1.3N) in the arrow direction under the following conditions.

Storage conditions/Note things

- (1) Storage temperature and humidity conditions :
 - 1. Product packing with Carrier tape: $+5^{\circ}$ C ~ $+40^{\circ}$ C and less than 60% RH.
 - 2. Product alone: -20° C $\sim +60^{\circ}$ C and less than 60% RH.
- (2) Products should be used within 6 months.
- (3) The packaging material should be kept where no chlorine or sulfur exists in the air.
- (4) Do not touch the electrodes (soldering terminals) with fingers as this may lead to deterioration of solder ability
- (5) The use of tweezers or vacuum pick-ups is strongly recommended for individual components.
- (6) Bulk handling should ensure that abrasion and mechanical shock are minimized.

SAMPLE ACKNOWLEDGE CHANGE RESUME

DATE: 2019-8-16

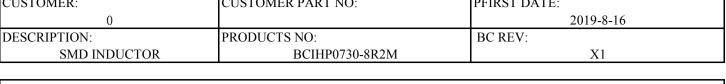
CUSTOMER:	CUSTOMER PART NO:	PFIRST DATE:
0		2019-8-16
DESCRIPTION:	PRODUCTS NO:	BC REV:
SMD INDUCTOR	BCIHP0730-8R2M	X1
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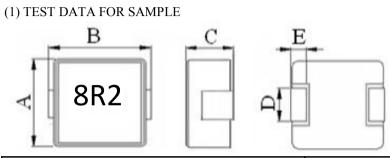
		Belli 07	50 01(21(1	Ai		
REV		Change content	Change reason	Modify	Date	
01	00	首次	首次送样	chenlinli	2019-8-16	

TEST DATA

DATE: 2019-8-16

CUSTOMER:	CUSTOMER PART NO:	PFIRST DATE:
0		2019-8-16
DESCRIPTION:	PRODUCTS NO:	BC REV:
SMD INDUCTOR	BCIHP0730-8R2M	X1





LOT NO.					
DIMENS	SIONS (UNIT:mm)			
A	6.80	Max			
В	7.30	Max			
С	3.00	Max			
D	3.00	±0.3			
Е	1.60	±0.3			

	TEST ITEM	SPEC	TEST CONDITION
1	Inductance (uH)	8.2 ± 20%	200kHz/0.25v/0A.
2	$Rdc (m\Omega)$	68.0 Max	
3	(6) (Isat)(A)Saturation Current DC Amps	6.0 △L≦20%	
4	(5) (Irms)(A)Heat Rating Current DC Amps	4.0 △T≦40°C	

MEAS ITEM	A	В	С	D	Е		1	2	3
SUGGEST	6.80	7.30	3.00	3.00	1.60		8.2	68.0	6.0
SUGGEST	Max	Max	Max	±0.3	±0.3		± 20%	Max	△L ≦ 20%
1	6.61	7.13	2.91	3.00	1.60		8.02	62.35	83%
2	6.59	7.11	2.92	3.00	1.60		8.26	61.54	84%
3	6.65	7.13	2.89	3.00	1.60		8.04	61.04	86%
4	6.62	7.14	2.87	3.00	1.60		8.10	60.59	85%
5	6.64	7.13	2.92	3.00	1.60		8.08	62.12	81%
6	6.62	7.09	2.94	3.00	1.60		8.11	61.79	83%
7	6.65	7.16	2.87	3.00	1.60		7.85	62.38	82%
8	6.68	7.18	2.84	3.00	1.60		8.00	61.35	84%
9	6.59	7.09	2.86	3.00	1.60		8.08	61.33	82%
10	6.64	7.14	2.88	3.00	1.60		8.03	62.14	81%
11									
12									
13									
14									
15									
max	6.68	7.18	2.94				8.26	62.38	86.0%
min	6.59	7.09	2.84				7.85	60.59	81.0%
σ	0.027	0.027	0.030				0.097	0.566	0.016
X	6.63	7.13	2.89				8.06	61.66	83.1%
Cpk	2.11	2.11	1.22				6.12	3.73	109.19

2.TEST CONDITION	APPROVED BY
TEMP. 25°C R.H. 65%	
3.TEST INSTRUMENTS	ouyangweijun
☐HP-4284A METER ☐CH-3305 METER	
■HP-4285A METER □CD1068+CD1320 METER	CHECKED BY
☐HP-4191A METER ☐VR113+VR712 METER	ouvengueiiun
☐ CH101 LCR,METER ☐ WK3260B+WK3265B METER	ouyangweijun
■ VR116+VR7220 METER VR562 METER	DRAWN BY
☐CH-3200 METER ☐CH-502B DCR METER	chenlinli
□CH-310 METER	Chemini

■GENERAL CHARA	CTERISTICS	page. 1
Operation Temperature	-40°C to +125°C (Includes temperature when the co	il is heated)
External Appearance	On visual inspection, the coil has no external defects	S.
Solder Ability Test	More than 90% of terminal electrode should be covered at large 1 After fluxing, component shall be dipped in a dipped in a melted. Solder:bath at $235^{\circ}\text{C} \pm 5^{\circ}\text{C}$ for 5 ± 0.5 senonds	Preheating Dipping Natural cooling
Heat endurance of Solderin	1.Components should have not evidence of electrica 2.Inductance: within±10% of initial value. 3.Impedance: within±10% of initial value. Preheat:150±5°C 60seconds. Solder temperature: 250±5°C. Flux: rosin. Dip time:10±0.5seconds.	Preheating Dipping Natural cooling
Terminal Strength	After soldering of X,Y withstanding at below condit off. (Refer to figure at below)	ions .The terminal should not Peel 5N:6
Insulating Resistance	Over $100M\Omega$ at $100V$ D.C. between coil and core.	
Dielectric Strength	No dielectric breakdown at 30V D.C. for 1 minute b	etween coil and core.
VibrationTest	Inductance deviation within +10% after vibration for orientations at sweep vibration(10-~55-~10HZ)with	
Drop test	Inductance deviation within +10% after being dropp shock Attitude upon a rubber block method shock to orientations	· · · ·

S Application Notice/Handling

- 1. Storage Conditions
- 1. Storage Conditions

To maintain the solder ability of terminal electrodes:

- (1) Temperature and humidity conditions: less than 40°C and 70% RH.
- (2) Products should be used within 6 months.
- (3) The packaging material should be kept where no chlorine or sulfur exists in the air.
- Handling
- (1) Do not touch the electrodes(soldering terminals) with fingers as this may lead to deterioration of solderability.
- (2) The use of tweezers or vacuum pick-ups is strongly recommended for individual components.
- (3) Bulk handling should ensure that abrasion and mechanical shock are minimized.

■GENERAL CHARACTE	ERISTICS	page. 2
TEST	Required Characteristics	Test Method/Condition
High Temperature StorageTest Reference documents: MIL-STD-202G Method108A	 No case deformation or change in appearance ΔL/L≤10% ΔQ/Q≤30% ΔDCR/DCR≤10% 	High temperature 25°C High temperature 25°C 1H 1H 96H Test Time Temperature: 125°C±2°C Time: 96±2 hours. Tested not less than 1 hour, nor more than 2 hours at room.
Low Temperature Storage Test Reference documents: IEC 68-2-1A 6.1 6.2	 No case deformation or change in appearance ΔL/L≤10% ΔQ/Q≤30% ΔDCR/DCR≤10% 	High temperature Tested not less than 1 hour, nor more than 2 hours at room.
Humidity Test Reference documents: MIL-STD-202G Method103B	 No case deformation or change in appearance ΔL/L≤10% ΔQ/Q≤30% ΔDCR/DCR≤10% 	1. Dry oven at a temperature of 40°C±2°C for 96hours 2. Measurements At the end of this period 3. Exposure: Temperature: 40°C±2°C. Humidity:93±2hoyrs. 4. Tested while the chamber. 5. Tested not less than 1 hour. Nor more than 2 hours at room temperature.
Thermal Shock Test Reference documents: MIL-STD-202G Method107G	 No case deformation or change in appearance △L/L≤10% △Q/Q≤30% △DCR/DCR≤10% 	First-40°C for 30 Minutes, last 125°C for 30 Minutes as 1 cycle. Go through 20 cycles.

■Application Notice/Handling

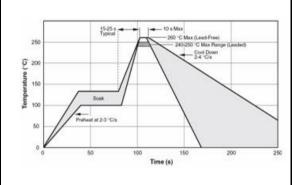
- (1) Temperature and humidity conditions: less than 40°C and 70% RH.
- (2) Products should be used within 6 months.
- (3) The packaging material should be kept where no chlorine or sulfur exists in the air.
- (4) Do not touch the electrodes (soldering terminals) with fingers as this may lead to deterioration of solder ability
- (5) The use of tweezers or vacuum pick-ups is strongly recommended for individual components.
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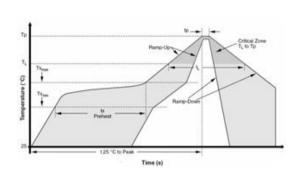
■THE CONDITION OF REFLOW(RECOMMENDATION)

page. 3

TYPICAL WAVE SOLDER PROFILE FOR LEAD -FREE THROUGH-HOLE PACKAGES

TYPICAL IR REFLOW PROFILE FOR LEADED AND LEAD -FREE SURFACE MOUNT PACKAGES





IPC/JEDEC J-STD-020C, Figure 5-1

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly 3 °C/second max.	
Average Ramp-Up Rate (Ts _{max} to Tp)	3 °C/second max.		
Preheat ± Temperature Min (Ts _{min}) ± Temperature Max (Ts _{max}) ± Time (ts _{min} to ts _{max})	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-180 seconds	
Time maintained above: ± Temperature (T _L) ± Time (t _L)	183 °C 60-150 seconds	217 °C 60-150 seconds	
Peak/Classification Temperature (Tp)	See Table 4.1	See Table 4.2	
Time within 5 °C of actual Peak Temperature (tp)	10-30 seconds	20-40 seconds	
Ramp-Down Rate	6 °C/second max.	6 °C/second max.	
Time 25 °C to Peak Temperature	6 minutes max.	8 minutes max.	

Table 4. Classification Reflow Profiles (per IPC/JEDEC J-STD-020C, Table 5.2)

Note 1: All temperatures refer to topside of the package, measured on the package body surface.

Package Thickness	Volume mm ³ <350	Volume mm³ ≥350
<2.5 mm	240 +0/-5 °C	225 +0/-5 °C
≥2.5 mm	225 +0/-5 °C	225 +0/-5 °C

Table 5. SnPb Eutectic Process - Package Peak Reflow Temperatures (per IPC/JEDEC J-STD-020C, Table 4.1)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 + 0 °C *	260 + 0 °C *	260 + 0 °C *
1.6 mm - 2.5 mm	260 + 0 °C *	250 + 0 °C *	245 + 0 °C *
≥2.5 mm	250 + 0 °C *	245 + 0 °C *	245 + 0 °C *

^{*} Tolerance: Process compatibility is up to and including the stated classification temperature (this means Peak reflow temperature + 0 °C. For example 260 °C + 0 °C) at the rated MSL level.

Table 6. Pb-free Process - Package Classification Reflow Temperatures (per IPC/JEDEC J-STD-020C, Table 4.2)

Note 1: The profiling tolerance is + 0 °C, -X °C (based on machine variation capability) whatever is required to control the profile process but at no time will it exceed -5 °C. Process compatibility at the peak reflow profile temperatures as defined in Table 4.2.

Note 2: Package volume excludes external terminals (balls, bumps, lands, leads) and/or nonintegral heat sinks.

Note 3: The maximum component temperature reached during reflow depends on package thickness and volume. The use of convection reflow processes reduces the thermal gradients between packages. However, thermal gradients due to differences in thermal mass of

SMD packages may still exist.

Note 4: Components intended for use in a "lead-free" assembly process shall be evaluated using the "lead-free" classification temperatures and profiles defined in Tables 4.1, 4.2 and 5.2 whether or not lead free.